

Q D

-60V P-Channel Enhancement Mode MOSFET

Description

The AP15P06D uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

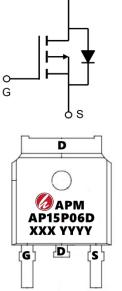
General Features

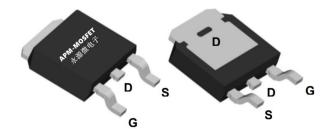
V_{DS} = -60V I_D =-18.8A

 $R_{DS(ON)} < 70m\Omega @ V_{GS}=10V (Type: 53m\Omega)$

Application

Brushless motor Load switch Uninterruptible power supply





Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS) 2500	
AP15P06D	TO-252-3	AP15P06D XXXX YYYY		
bsolute Maximu	m Ratings (T _c =25℃unless otherwise not	ed)		
Symbol	Symbol Parameter		Units	
Vds	Drain-Source Voltage	-60	V	
Vgs	Gate-Source Voltage	±20	V	
I₀@Tc=25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-18.8	А	
I _D @Tc=100°C	Continuous Drain Current, V _{GS} @ -10V ¹	-11	А	
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-4.3	А	
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ -10V ¹	-3.5	А	
Ідм	Pulsed Drain Current ²	-36	А	
EAS	Single Pulse Avalanche Energy ³	35.4	mJ	
las	Avalanche Current	-26.6	А	
P₀@Tc=25°C	Total Power Dissipation ⁴	34.7	W	
PD@TA=25°C	Total Power Dissipation ⁴	2	W	
Тѕтс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
Reja	Thermal Resistance Junction-Ambient ¹	62	°C/W	
R _θ JC	Thermal Resistance Junction-Case ¹	3.6	°C/W	

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Electrical Characteristics (T_A=25°Cunless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage V _{GS} =0V , I _D =-250uA		-60		Max.	V	
∆BVDSS /∆Tj				-0.03		v V/℃	
	BV _{DSS} Temperature Coefficient					V/C	
RDS(ON)	Static Drain-Source On-Resistance	V _{GS} =-10V , I _D =-12A		53	70	mΩ	
		V _{GS} =-4.5V , I _D =-8A		64	105		
VGS(th)	Gate Threshold Voltage V _{GS} =V _{DS} , I _D =-250uA		-1.2	-1.5	-2.5	V	
$ riangle V_{GS(th)}$	$V_{GS(th)}$ Temperature Coefficient			4.56		mV/℃	
IDSS	Drain-Source Leakage Current	$V_{\text{DS}}\text{=-48V}$, $V_{\text{GS}}\text{=}0\text{V}$, $T_{\text{J}}\text{=}25^\circ\!\mathbb{C}$			1	- uA	
		V _{DS} =-48V , V _{GS} =0V , TJ=55℃			5	uA	
IGSS	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA	
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-12A		15.4		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		13.5		Ω	
Qg	Total Gate Charge (-4.5V)			9.86			
Q _{gs}	Gate-Source Charge	V _{DS} =-48V , V _{GS} =-4.5V , I _D =-10A		3.08		nC	
Q _{gd}	Gate-Drain Charge			2.95		1	
Td(on)	Turn-On Delay Time			28.8			
Tr	Rise Time	V _{DD} =-15V , V _{GS} =-10V ,		19.8			
Td(off)	Turn-Off Delay Time	R _G =3.3□, I _D =-1A		60.8		ns	
T _f	Fall Time			7.2		1	
Ciss	Input Capacitance			1447			
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		97.3		pF	
Crss	Reverse Transfer Capacitance			70			
ls	Continuous Source Current ^{1,5}				-18	А	
ISM	Pulsed Source Current ^{2,5}	$V_G=V_D=0V$, Force Current			-36	Α	
VSD	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , TJ=25℃			-1.2	V	

Note :

 $1_{\mbox{\tiny V}}$ The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.

2. The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3、The EAS data shows Max. rating . The test condition is VDD=-25V,VGS=-10V,L=0.1mH,IAS=-26.6A

4. The power dissipation is limited by 150 $^\circ\!\!\mathbb{C}$ junction temperature

5. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.



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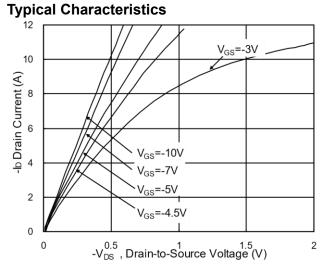


Fig.1 Typical Output Characteristics

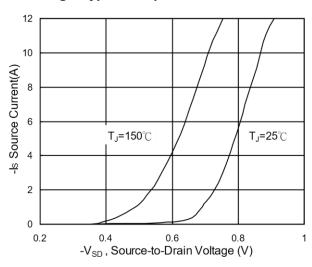
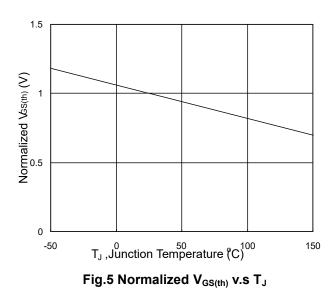


Fig.3 Forward Characteristics of Reverse



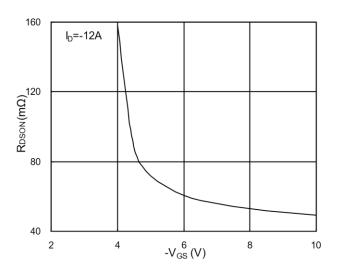


Fig.2 On-Resistance v.s Gate-Source

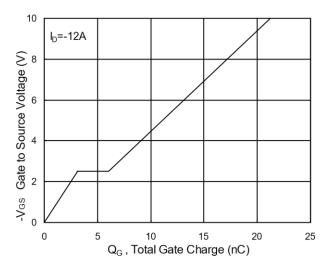
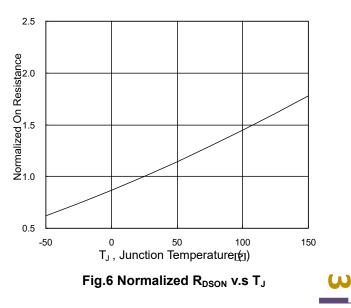


Fig.4 Gate-Charge Characteristics





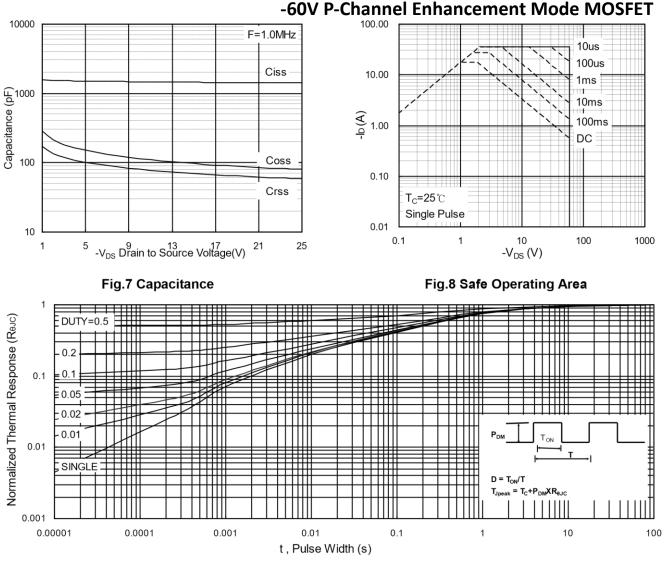


Fig.9 Normalized Maximum Transient Thermal Impedance

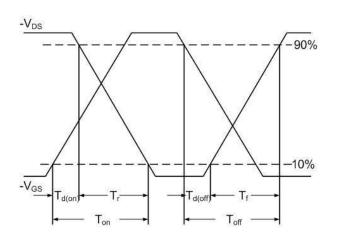
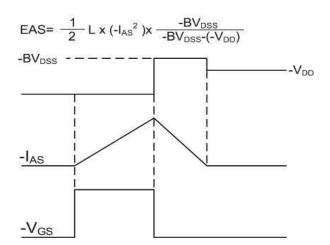
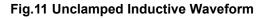


Fig.10 Switching Time Waveform



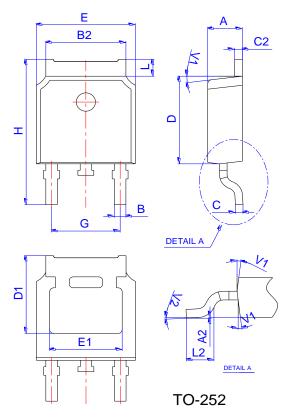


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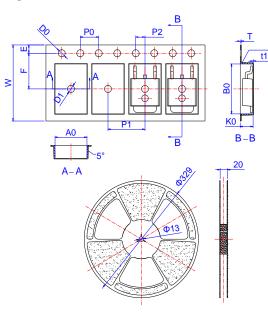
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Package Mechanical Data



	Dimensions					
Ref.	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
В	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
С	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			(.209REF	
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
Н	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

Reel Spectification-TO-252



	Dimensions					
Ref.	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
W	15.90	16.00	16.10	0.626	0.630	0.634
Е	1.65	1.75	1.85	0.065	0.069	0.073
F	7.40	7.50	7.60	0.291	0.295	0.299
D0	1.40	1.50	1.60	0.055	0.059	0.063
D1	1.40	1.50	1.60	0.055	0.059	0.063
P0	3.90	4.00	4.10	0.154	0.157	0.161
P1	7.90	8.00	8.10	0.311	0.315	0.319
P2	1.90	2.00	2.10	0.075	0.079	0.083
A0	6.85	6.90	7.00	0.270	0.271	0.276
B0	10.45	10.50	10.60	0.411	0.413	0.417
K0	2.68	2.78	2.88	0.105	0.109	0.113
Т	0.24		0.27	0.009		0.011
t1	0.10			0.004		
10P0	39.80	40.00	40.20	1.567	1.575	1.583

-5°MAX



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Edition	Date	Change
Rve3.8	2018/1/31	Initial release
Rve3.9	2018/5/25	Reduce CiSS and QG
Rve4.0	2021/4/13	Change layout format

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